STANDARD TRIACS

FEATURES

■ HIGH SURGE CURRENT CAPABILITY

■ COMMUTATION: (dV/dt)c>5 V/µs

■ BTA Family :

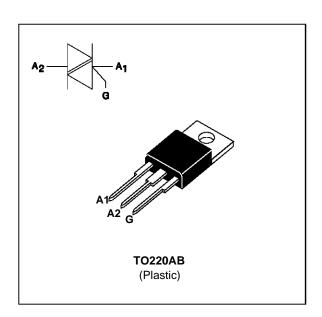
INSULATING VOLTAGE= 2500V(RMS)

(UL RECOGNIZED: E81734)

DESCRIPTION

The BTA/BTB06 B/C triac family are high performance glass passivated PNPN devices.

These parts are suitables for general purpose applications where high surge current capability is required. Application such as phase control and static switching on inductive or resistive load.



ABSOLUTE RATINGS (limiting values)

Symbol	Parameter	Value	Unit		
IT(RMS)			Tc = 100 °C	6	А
	(360° conduction angle)	втв	Tc = 105 °C		
ITSM	1 = 1			63	Α
(Tj initial = 25°C)		tp = 10 ms	60		
ı2t	I ² t value	tp = 10 ms	18	A ² s	
dl/dt	Critical rate of rise of on-state current Gate supply: IG = 500mA dig/dt = 1A/µ	Repetitive F = 50 Hz	10	A/μs	
		Non Repetitive	50		
Tstg Tj	Storage and operating junction temperature range			- 40 to + 150 - 40 to + 125	°C °C
TI	Maximum lead temperature for soldering during 10 s at 4.5 mm from case			260	°C

Symbol	Parameter	BTA / BTB06 B/C					
		400	600	700	800		
V _{DRM} V _{RRM}	Repetitive peak off-state voltage Tj = 125 °C	400	600	700	800	V	

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THERMAL RESISTANCES

Symbol	Parameter	Value	Unit	
Rth (j-a)	Junction to ambient	60	°C/W	
Rth (j-c) DC	Junction to case for DC BTA		4.4	°C/W
		втв	3.2	
Rth (j-c) AC	Junction to case for 360° conduction angle	вта	3.3	°C/W
	(F= 50 Hz)		2.4	

GATE CHARACTERISTICS (maximum values)

PG (AV) = 1W PGM = 10W (tp = 20 μ s) IGM = 4A (tp = 20 μ s) VGM = 16V (tp = 20 μ s).

ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions		Quadrant	Suffix		ffix	Unit
					В	C	
IGT	V _D =12V (DC) R _L =33Ω	Tj=25°C	1-11-111	MAX	50	25	mA
			IV	MAX	100	50	
VGT	V _D =12V (DC) R _L =33Ω	Tj=25°C	I-II-III-IV	MAX	1.	.5	V
VGD	VD=VDRM RL=3.3kΩ	Tj=110°C	I-II-III-IV	MIN	0.	.2	V
tgt	$VD=VDRM$ $IG = 500mA$ $dI_G/dt = 3A/\mu s$	Tj=25°C	I-II-III-IV	TYP	2		μs
IL	I _G =1.2 I _G T	Tj=25°C	I-III-IV	TYP	40	20	mA
			II		70	35	
l _H *	I _T = 500mA gate open	Tj=25°C		MAX	50	25	mA
V _{TM} *	I _{TM} = 8.5A tp= 380μs	Tj=25°C		MAX	1.0	65	V
IDRM	V _{DRM} Rated	Tj=25°C		MAX	0.0	01	mA
IRRM	VRRM Rated Tj=110°C			MAX	X 0.5		
dV/dt *	Linear slope up to V _D =67%V _{DRM} gate open	Tj=110°C		MIN	250	100	V/μs
(dV/dt)c *	(dl/dt)c = 2.7A/ms	Tj=110°C		MIN	10	5	V/µs

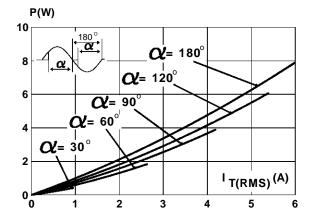
^{*} For either polarity of electrode A2 voltage with reference to electrode A1.

ORDERING INFORMATION

Package	IT(RMS)	V _{DRM} / V _{RRM}	Sensitivity Specification		
	A	V	В	С	
ВТА	6	400	Χ	X	
(Insulated)		600	Χ	X	
		700	X	X	
		800	Χ	X	
втв		400	Χ	X	
(Uninsulated)		600	X	X	
		700	Х	X	
		800	X	X	

Fig.1: Maximum RMS power dissipation versus RMS on-state current (F=50Hz). (Curves are cut off by (dl/dt)c limitation)

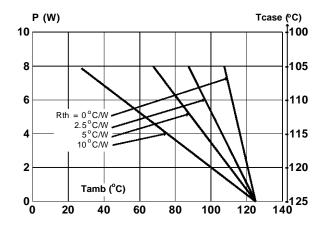
rsus RMS **Fig.2**: Correlation between maximum RMS power dissipation and maximum allowable temperatures (T_{amb} and T_{case}) for different thermal resistances heatsink + contact (BTA).

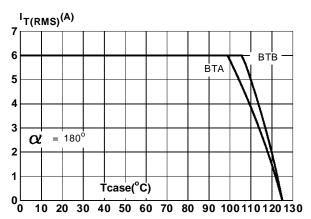


P (W) Tcase (°C) 10 -95 = 0 ° C/W Rth 8 -100 105 6 -110 -115 2 120 Tamb (°C) 0 125 20 40 60 80 100 120 140

 $\label{eq:Fig.3} \textbf{Fig.3} : \textbf{Correlation} \ \ \text{between} \ \ \text{maximum} \ \ \text{mean} \ \ \text{power} \\ \text{dissipation} \ \ \text{and} \ \ \text{maximum} \ \ \text{allowable temperatures} \ \ (T_{amb} \\ \text{and} \ \ T_{case}) \ \ \text{for different thermal resistances heatsink} \ \ + \\ \text{contact (BTB)}.$

Fig.4: RMS on-state current versus case temperature.





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Fig.5: Relative variation of thermal impedance versus pulse duration.

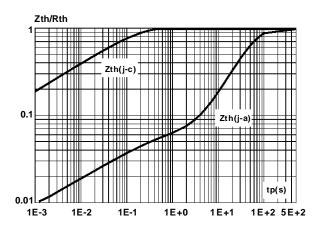


Fig.7: Non Repetitive surge peak on-state current versus number of cycles.

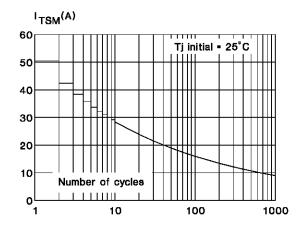


Fig.9: On-state characteristics (maximum values).

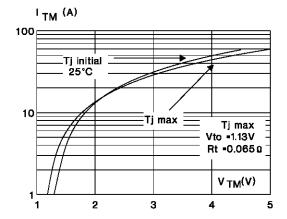


Fig.6: Relative variation of gate trigger current and holding current versus junction temperature.

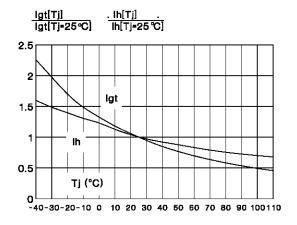
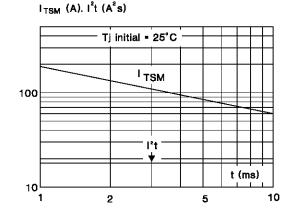
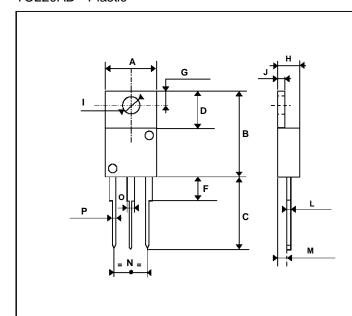


Fig.8 : Non repetitive surge peak on-state current for a sinusoidal pulse with width : $t \le 10ms$, and corresponding value of I^2t .



PACKAGE MECHANICAL DATA

TO220AB Plastic



REF.	DIMENSIONS				
	Millimeters		Inches		
	Min.	Max.	Min.	Max.	
Α	10.20	10.50	0.401	0.413	
В	14.23	15.87	0.560	0.625	
С	12.70	14.70	0.500	0.579	
D	5.85	6.85	0.230	0.270	
F		4.50		0.178	
G	2.54	3.00	0.100	0.119	
Н	4.48	4.82	0.176	0.190	
-	3.55	4.00	0.140	0.158	
J	1.15	1.39	0.045	0.055	
L	0.35	0.65	0.013	0.026	
М	2.10	2.70	0.082	0.107	
N	4.58	5.58	0.18	0.22	
0	0.80	1.20	0.031	0.048	
Р	0.64	0.96	0.025 0.03		

Cooling method : C Marking : type number

Weight: 2.3 g

Recommended torque value : 0.8 m.N. Maximum torque value : 1 m.N.

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